# SPECIFICATION FOR CONNECTOR USED FOR FPC/FFC WITH 1mm CONTACT SPACING SLW R/S- LF

#### 1. SCOPE

This specification covers the requirements for the connector (SLW\_\_R/S-\_\_LF) with 1mm spacing to which the edge of FPC (Flexible Printed Circuit) and FFC (Flexible Flat Cable) can be connected by Zero-Insertion-Force method.

#### 2. APPLICABLE STANDARDS

JIS C 5402

Method for Test of Connectors for Electronic Equipment

UL - 94

TESTS FOR FLAMMABILITY OF PLASTIC MATERIALS FOR PARTS IN

DEVICES AND APPLIANCES.

### 3. CATALOG No. STRUCTURE

		SLW 1	0 R	· <del>-</del>	1C7	LF
Series —			ГТ	-		T
Number of Contacts —						
Connector Typevv —						
R: Right angle type	•					
S: Straight type						
Variation —						
Lead Free		 				

## 4. CONNECTOR SHAPE, DIMENSIONS

See attached drawings.

#### 5. MATERIALS

See attached drawings.

## 6. ACCOMMODATED CONDUCTORS (FPC/FFC)

See attached drawings.

# 7. ACCOMMODATED P.C.BOARD (P.C.B on which the connector is mounted)

See attached drawings.

#### 8. RATING

8-1. Voltage: A.C.100V

D.C.100V

8-2. Current: A.C.1A

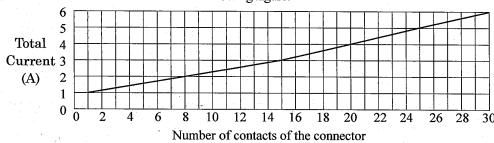
D.C.1A (Refer to the following note.)

8-3. Operating Temperature : -55°C ~ +85°C

(Including terminal temperature rises)

#### **NOTE**

Allowable maximum current for one contact is 1A. Total allowable current for a whole connector is the value which is shown in the following figure.



## 9. PERFORMANCE CHARACTERISTICS

# 9-1. Electrical Performance

No.	Test Item	Test Method	Requirements		
		1)Measure contact resistance between	1)Initial value		
		V <sub>1</sub> -V <sub>2</sub> by voltage drop method by	: Less than 30mΩ		
		the following circuit.	2)Contact resistance after the		
			test is in accordance with the		
4		5mm <u>Connector</u>	value specified in each test		
	-	V1   -	item.		
	Contact	P.C.B.	·		
9-1-1	resistance				
	Toblottanoe				
		Connductor V3			
		2)Open circuit voltage			
	e figur	: Less than A.C.20mV	n e		
		3)Test current: Less than A.C.20mA			
		1)Measure insulation resistance	1)More than 500MΩ		
		between adjacent contacts in a			
9-1-2	Insulation	connector individual.			
	resistance	2)Test voltage : D.C.500V			
1.5		3)Read value one minute after			
		applying test voltage.			
	Dielectric	1)For one minute, apply A.C.500V	1)Free from any short circuit		
9-1-3	withstanding	between adjacent contacts in a	and insulation breakdown.		
	voltage	connector individual.	The state of the s		
	8	2)Set current : A.C.1mA			

#### 9-2. Mechanical Performance

	T . r			
No.	Test Item	Test Method	Requirements	
		JIS C 0040		
	1 Vibration (Sinusoidal)	1) Frequency range: 10 ~ 500Hz	1)During the test, no circuit	
		2) Amplitude: 0.75mm	opening for more than 1µs.	
9-2-1		or Acceleration: 100m/s <sup>2</sup>	2)Free from any defect such as	
		3) Sweep rate: 1 octave/minute	break, deformation, loosing	
		4) Kind of test: Sweep endurance test	and falling off etc. on each	
		5)Test time: 10 cycles	portion of the connector.	
	Durability	1)Measure contact resistance before	1)Initial contact resistance	
		and after the test by the method in	: Less than 30mΩ	
•		clause 9-1-1 by mating the	2)Contact resistance after the	
		accommodated conductor specified	test: Less than 50mΩ	
9-2-2	(Slider operation)	in clause 6.	3)Free from any defect such as	
	(Silder operation)	2)Number of slider open and close	break etc. on the connector	
		20 times	and the conductor.	
		(Insert and extract the conductor		
		for each opening of the slider.)		

	Category	1			
No.	Test Item	Test Method	Requirements		
		JIS C 0022			
		1)Measure contact resistance before	1)Initial contact resistance		
		and after the test by the method in	: Less than 30mΩ		
		clause 9-1-1 by using the	2)Contact resistance after the		
		accommodated conductor specified	test: Less than $50\text{m}\Omega$		
		in clause 6.	3)Insulation resistance after		
		2)Measure insulation resistance after	the test : More than $100M\Omega$		
			the test . More than 100M122		
9-3-1	Damp heat	the test by the method in clause 9-1-2.			
9-3-1	(Steady state)				
		3)Bath temperature : 40°C			
		4)Bath humidity: 90 ~ 95%			
		(relative humidity)			
	*	5)Period of exposure: 48 hours			
		6)Expose conductor and connector			
		after mating them and dry them			
		naturally after posttreating.			
		(Without insertion and separation)	•		
		JIS C 0023			
		1)Measure contact resistance before	1)Initial contact resistance		
		and after the test according to the	: Less than $30\text{m}\Omega$		
		method in clause 9-1-1 by using	2)Contact resistance after the		
		accommodated conductor specified	test: Less than $50m\Omega$		
9-3-2	Salt spray	in clause 6.	test · Less than 50m2		
9-3-2	San spray				
	* 	2)Salt solution concentration: 5%			
		3)Period of exposure: 48 hours			
		4)Expose conductor and connector in			
		mated condition and dry them			
		naturally posttreatment. (24 hours)			
		JIS C 0025			
		1)Measure contact resistance before	1)Initial contact resistance		
		and after the test according to the	: Less than 30mΩ		
1		method in clause 9-1-1 by using	2)Contact resistance after the		
		accommodated conductor in clause	test: Less than 50mΩ		
		6.	3)Free from any defect such as		
		2)One cycle of temperature is as	crack, warping and		
	Change of	follow and test 5 cycles.	deformation etc. on each		
9-3-3	temperature	Step Temp.(°C) Time(min.)	portion the connector.		
1	Tarana Ta	1 -55±3 30	portion the connector.		
		$\begin{array}{c ccccccccccccccccccccccccccccccccccc$			
		$\frac{2}{3}$ $\frac{23\pm2}{85\pm2}$ $\frac{2}{30}$			
		$\begin{array}{c ccccccccccccccccccccccccccccccccccc$			
		1 23-2 2 3			
1		3)Expose conductor and connector by			
1		mating them and leave them under			
Ŀ		normal temperature.			

9-4. Other performance

No.	Test Item	Test Method	Requirements		
9-4-1	Soldering (Solderability)	JIS C 0050 Test Method : Ta  1) Test connector is soldered by dipping in inactive rosin family flux after mounted on P.C.Board.  Soldering bath temp.(°C) Dipping time(s)  235±5 5±0.5	1)Actual soldered area must be more than 90% of the dipped area intended to be soldered.		
9-4-2	Soldering (Resistance to	JIS C 0050 Test Method : Tb  1) Test connector is soldered by the following condition after mounted P.C.Board.	1)Free from any damage on concerning feature and contacting performance after soldered.		
. 2	soldering)	Soldering bath temp.(°C)Dipping time(s) $350\pm10$ $3.5\pm0.5$ $260\pm5$ $10.0\pm1$			
9-4-3	Conductor retention force (Reference)	Measure initial separation force by using accommodated conductor specified in clause 6 after locked.	1)More than 0.49N(0.05kgf) /contact		

### 10. INDICATION AND PACKAGING

#### 10-1. Indication

- 1) Catalog number and lot number are not indicated on the connector.
- 2) Catalog number and quantity shall be indicated on the surface on the package box.

#### 10-2. Packaging

1) The connector individuals are put into the package box with specified quantity in accordance with the method specified in the separate packaging specification.

#### 11. Remarks

- 11-1. Since this connector can not be used for CIC (Conductor such as silver paste, carbon etc.) as accommodated conductor, please consult us separately.
- 11-2. In case of using this connector as multi-conductors, please mate by pushing slider center portion (Excepting conductor guide portion) by all means since sometimes slider center portion does not go down perfectly (Especially in case of combination with FFC of more than 21 conductors.)
- 11-3. Retention force for accommodated conductor specified in clause 9-4-3 differs due to it's kind, structure and surface treatment of conductor. Therefore, the value of retention force specified in the clause for performance is reference value.
- 11-4. Please refer to the "Handling procedures and remarks" before use.